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 2021\_09\_01 - Leo Greiner - DRAFT

2 EIC hybrid detector cost estimate - (same as all-silicon with outer barrel layers removed and implications propagated through the rest of the estmate)

First pass for a cost estimate for the all-silicon EIC detector concept. Note that the costs are broken out into detector components to allow for easy addition/removal of all-silicon components for modification. The costing of the silicon and modulization is at the end and will need to be made as pa No overhead or yearly escalation in materials costs.

5 All flex PCBs in the staves and discs are Aluminum conductor available at the CERN PCB shop.

6 Most of the estimates come from engineering judgement

7 Not all procurement numbers are fully vetted, "\*" in verify/scrub column needs checking

8 Assumes CMM available at assembly sites (add ~150k per site if not)

9 Silicon costs are separate from layer/disc assembly and have it's own WBS. Scale with area

10 Signal multiplexing boards are in the services WBS

This WBS ends with an assembeled and tested detector in BNL. Installation and testing is another set of tasks not in the estimate.

12 P	laces where one would wish to	run parallel assembly sites are marked with	n yellow. The f	full effort is include	d, tooling and i	machinery will ne		plied by the r	number of as	ssembly sites.	See co	omments	
			Mech	Mech	Electrical	Electrical	Postdoc (instrume						
14	MOC	task	engineer	Technician	Engineer	Technician	ntation)	student		materia	ıl	comments	vorify/comb
14 15	WBS	task staves	(days)	(days)	(days)	(days)	(days)	(days)	(days)	(\$k)		comments assumes ITS-2 like truss staves and ITS-3 like bent silicon	verify/scrub
16 17		vertexing layers carbon foam design		10 2	,					5		most of this is a modification of ITS-3 design, hours reflect that	
18		support shell design		10 2	- !			_		5	•	most of this is a mounication of 113 3 design, hours reflect that	
18 19 20 21		test and iteration fabricate carbon foam		5 10	) )			5 5		2	3 5		
21		fabricate support shell stave transition pieces/bypass capacitor		5 10	)			5		2	5		
22		assembly design		10	3 1	5	3	5		5	1	\$2k PCB layout, fabricate test PCBs \$2k, 3d printing of parts \$2k, testing	
23		test fab and iteration		8 8	3 1	0	8	5 :	10	5	5	material 1k	
		stave transition pieces/bypass capacitor										16 stitched sensor rows for vertexing (2 half-layers) 64 assemblies needed. Make 70 (10% spares and yield reserve) \$100 for 3D printed parts, \$200	
24 25		assembly fabricate assembly tooling design		5 5 15 5	; ;	5	1	5 5	5	3 5	21	per PCB (loaded), acceprance testing, QA	
26		test fab and iteration assembly tooling fabricate		15 15 10 15			1	0 :	10	5	8	7k for tooling, \$500 CFC, \$500 misc 5k tooling modification	
28		silicon acceptance testing				_		8	4	2	7	4 hr per stitched row, \$6k for ITS-3 test station, 1k for misc	
30		assembly of half layers metrology		5 10 1 4	,	5		.0		1	1	adhesives, supplies 1 day per half layer	
31		testing		1 1		1	1 1	0	4			as per acceptance testing	
25 26 27 28 29 30 31 32 33 34		vertexing layers total	1	.08 95	3	6 1	8 7	8 3	33	53	61		
35 36 37		middle layers stave mech design		25 5	:			5			5	1.57 m <sup>2</sup> procure misc parts and integrate into design	
37		stave mech tooling design		25 5	;			3			5		
38		test fab and iteration		10 25	;	2	2 2	.5 :	10	10	18	\$15k tooling, 1k CFC, 2k testing setup (bending, twist, metrology) grounding of CFC, integration into grounding plan	
												54 staves needed for ML, build 64 staves (6 spare, 4 for yield issues) assume 1 stave truss/day assembly and 1 day to fabricate truss parts	
39 40 41		stave mech fabrication cooling plate design		20 128 10 5		5	5 2	.0 4	40	15 1	28	(should run pipelined), \$400 for parts	
41		cooling plate tooling design		15 5	;			2		1		10k for tooling 2k for mine folk 2 mines to the till t	
42		test fab and iteration		10 15				5	5	5	15	10k for tooling, 2k for misc, fab 2 pieces, test with metrology, tooling modify \$3k	
42 43 44		cooling plate fabrication flex PCB design		5 32	? 1	7	2	5 2	5	1 2	6 1	assume 4 hr per cold plate fab and assy pipelined schematic and layout parameters, parts selection	
		test fab and iteration flex PCB design			1	n 1	0	5	5	5	12	6k layout, this is Al flex PCB, only available from CERN PCB shops. 3k per test piece (~1 m long), 2 test pieces	
45 46		fabrication flex PCB design				8		8	8		.05	fabricate 70 @ 1.5k each - acceptance testing, QA	
47		stave transition pieces/bypass capacitor assembly design		10	3 1	5	3	5		5	1	different design from vertexing layers	
48		test fab and iteration		8 8	3 1	0	8	5 :	10	5	5	\$2k PCB layout, fabricate test PCBs \$2k, 3d printing of parts \$2k, testing material 1k	
		stave transition pieces/bypass capacitor assembly fabricate		ς τ		5	1	5	5	3	21	Make 70 (10% spares and yield reserve) \$100 for 3D printed parts, \$200 per PCB (loaded), acceptance testing, QA	
<ul><li>49</li><li>50</li><li>51</li></ul>		assembly tooling design		25 5	5	5			5	5	1		
		test fab and iteration		15 20		5		.0 :	10		25	15k for tooling, 2k for misc, 8k for tooling mod 15k per station of tooling. Assume 2 stations for assembly at each site, 2	
52		assembly tooling fabrication		10 15	<b>;</b>	2	2	5	5	1	60	sites assume modules are 51 x 90 mm. We need 4 x 64 staves = 256 modules.	
53		silicon acceptance testing				1	1 2	6 2	26	2	10	Test 5 per day by postdoc/student. 10k for testing station In pipeline, assume 3 people can assemble 1 stave in 1.5 days (glue	
54		assembly of staves		5 96		5 9	6 9	6 4	40	20	20	latencies) + 10k to set up clean room assembly space @ 2 sites 2 staves per day metrology	
56		metrology testing		1 32	-		3	2 :	16	16	1	individual completed stave testing @ 2 per day	
55 56 57 58 59 60 61		middle layers total	1	.99 404	. 9	0 14	3 26	6 19	90	112 3	39		
59 60		discs										assumes disc plates of carbond foam between face sheets	
61		half discs 1, -1										0.22 m^2	
62		flex PCB design			2	0	3	3		5		multiple flex PCB designs to cover the half disc surface, designs similar but not identical, and different sizes	
63		test fab and iteration flex PCB design			1	3 1	5	8	8	5	17	3 design layout @ 1.5k each + 2k each for fab of 2 pieces each. Testing and QA	
64		fabrication flex PCB designs				3	5	1	1	1	22	assume 3 flex PCBs per half disc @ 1.5k each with 1 spare/yield each	
65		plate design		15	,	,	3	3	-	3			
66 67		test fab and iteration plate design		2 8				5	5	5	3	2k tooling, 1k materials. layup, trim, machine, test mechanically and thermally, includes cooling (water or air)	
67		half-disc plates fabricate disc transition pieces/bypass capacitor		2 10	)			3	3	3	6	need 4, make 6 (may be differences) 1k in materials each	
68		assembly design		10	3 1	5	3	5		5	1	use ML starting point	
		toot foli and its and its		0		0	0	_	10	r	-	hope to use same design for all discs so only do this once. \$2k PCB layout,	
69		test fab and iteration stave transition pieces/bypass capacitor		8 S	3 10		ŏ		10	5	5	fabricate test PCBs \$2k, 3d printing of parts \$2k, testing material 1k need 12, fab 16. \$100 for 3D printed parts, \$200 per PCB (loaded),	
70 71 72		assembly fabricate assembly tooling design		1 3	; ;	1	3	3	2 5	1 5	5 1	acceptance testing, QA small disc	
72 73		test fab and iteration assembly tooling fabricate		5 8	3	1	1	3	3	3	5 4	5k for tooling. Assembly in one location 3k for fix/mod, 1k incidentals	
				_		<b>-</b>	0	-	10	-	7	assume 1 week/half disc assembly 3 people 2k for adhesives, misc.	
74 75 76 77		assembly of modules onto disc halves metrology		1 20	) !	1 2	0 2	0 :	10	5	2	assembly materials 2 disc halves per day	
76 77		testing						2	1	1		2 disc halves per day	
78 79		half discs 1, -1 total		54 73	6	4 5	8 6	3 !	50	49	71		
80		half discs 2, -2										0.83 m^2	
81		flex PCB design			3	0	4	4		5		multiple flex PCB designs to cover the half disc surface, designs similar but not identical, and different sizes	
82		test fab and iteration flex PCB design			1	5 1	8 1	.0 :	10	7	33	6 design layout @ 1.5k each + 2k each for fab of 2 pieces each. Testing and QA	
		fabrication flex PCB designs					5	5	5		60	assume 6 flex PCBs per half disc (see power layout proposal) with one spare each at \$2k per flex PCB 1 spare/yield each	
83 84		plate design		15		-	_	3	_	3			
85		test fab and iteration plate design		4 8				5	5	5	6	5k tooling, 1k materials. layup, trim, machine, test mechanically and thermally, includes cooling (water or air)	
86		half-disc plates fabricate stave transition pieces/bypass capacitor		2 10	)			3	3	3	6	need 4, make 6 (may be differences) 1k in materials each need 24, fab 26. \$100 for 3D printed parts, \$200 per PCB (loaded),	
87 88		assembly fabricate assembly tooling design		1 3 10 3	; •	1	3	5	2	1 5	9 1	acceptance testing, QA. All discs same design larger disc	
		, , ,						_	_	r	2	2k tooling, 1k materials. layup, trim, machine, test mechanically and	
89 90		test fab and iteration assembly tooling fabricate		5 8 2	<b>5</b>	1	1	2	2	5 2	3 4	thermally, includes cooling (water or air) 3k for fix/mod, 1k incidentals	
91		assembly of modules onto disc halves		2 40	)	2 4	0 4	.0 2	20	10	2	assume 2 week/half disc assembly 3 people 2k for adhesives, misc. assembly materials	
92 93		metrology		2	<u>!</u>	,		2	1	1		2 disc halves per day 2 disc halves per day	
75		testing							1	т		د ماعد العابردي لمحا سعة	

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94 95 96 97	half discs 2, -2 total	41	82	52	71	84	58	52	124	
97	half disc 3, 4, 5, -3, -4, -5									3.52 m^2 8 design / half disc. multiple flex PCB designs to cover the half disc surface,
98	flex PCB design			35	6	6		5		designs similar but not identical, and different sizes 8 design layout @ 2k each + 3k each for fab of 2 pieces each. Testing and
99	test fab and iteration flex PCB design			18	20	12	12	8	56	QA assume 8 flex PCBs per half disc (see power layout proposal). We need 12
100	fabrication flex PCB designs			3	5	5	5	5	336	half-discs *8 PCB designs = 96 flex PCBs. with 2 spare of each type. at \$3k per flex PCB
101	plate design	15	3			3	F	3	6	12 half plates - all same size  10k tooling, 2k materials. layup, trim, machine, test mechanically and  thermally, includes earling (water or air)
102	test fab and iteration plate design half-disc plates fabricate	4 5	10 36	1	1	5 10	5 10	5 10	31	thermally, includes cooling (water or air)  12 plates needed, make 14. 2k materials each. 3k misc adhesives, misc. 3  days/plate in production
104	stave transition pieces/bypass capacitor assembly fabricate	1	3	1	3	5	2	1	32	need 96, fab 105. \$100 for 3D printed parts, \$200 per PCB (loaded), acceptance testing, QA. All discs same design
105	assembly tooling design	15	5				5	5	1	larger disc  10k tooling, 1k materials. layup, trim, machine, test mechanically and
106 107	test fab and iteration assembly tooling fabricate	10 5	15 10	1	1	5 2	5 2	5 2	3 20	thermally, includes cooling (water or air)  10k for tooling x 2 assembly sites
108	assembly of modules onto disc halves	20	270	20	180	180	100	40	16	larger job. 3 weeks/half disc assembly for 3 people. 8k materials per site
108 109 110 111 112 113	metrology testing		12 12							1 disc half per day 1 half disc / day
112 113	half disc 3, 4, 5, -3, -4, -5 total	75	376	79	216	233	146	89	501	
114	mechanics mechanics for installtion and suport of									
115 116 117 118	discs									assembly of disc banks comes in this WBS
117 118	support cones design support cones tooling design	30 20	5			10 5		10 5		4 x half cones
119	support cones test pieces fabricate support cones tooling design test and	5	15			10	5	5	30	25k tooling, 5k materials and closeouts
120 121 122 123	iteration support cones fabricate	10 3	10 50			5 10	5 10	10 10	10 20	includes testing and 10k change to tooling 4 cones 5k each materials and closeouts 2 people, 1 week per + 1 w
123	support cylinders design support cylinders tooling design	15 10	5			5		5 5		4 x half cylinders
124	support cylinders test pieces fabricate support cylinders tooling design test	3	10			10	10	5	20	15k tooling, 5k materials and closeouts
125 126 127	and iteration support cylinders fabricate	8	10 60			10 15	10 15	10 10	8 20	8k change to tooling 4 cyl 5k each materials and closeouts 2 people, 1.5 week per + 1 w
	disc support system design	40	5			25		25	15	clamps, supports, rails?, fastening points in cyl and cones, etc. 15k
129	disc support system test fab disc support system test and iterate disc support system fab	5 15 7	15 15 35			15 15 20	20	10	15 15 80	materials for mock up, tooling for positioning in all cones and cylinders, 10k per cyl/cone
131 132	assembly and testing assembly of disc bank halves	3 20	15 30	5	5	15 30	15 20	20	2	in all cories and cylinders, tok per cyl/corie
128 129 130 131 132 133	testing of disc bank halves	20	30	J	2	20	20	20	2	
135 136	mechanics for installtion and suport of discs total	197	280	5	7	225	130	150	222	
	mechanics for installtion and suport of									and the office well had an account the NVDC
137	staves ML end wheels and cylinder supports design	15	5	5		5		5		assembly of barrel halves comes in this WBS similar to OL => less design time
138	ML tooling design	15	5	3		5		5		Similar to OL => less design time
140	ML endwheels and cylinders test fab ML endwheels and cylinders test fab	5	20	2	2	10	10	10	25	20k tooling, 5k materials and closeouts
141	and iteration	10	15	1	1	15	10	15	8	8k tooling change 4 pieces each, 5k materials and closeouts each 1.5 weeks half-cylinders, 1
142 143	ML endwheels and cylinders fab ML assembly and testing	10 3	100 10	2 3	2 3	35 10	10 10	10 10	20	weeks half-endwheels 2 people
142 143 144 145 146	ML assembly of half-barrels ML testing of half barrels	3	11	1 1	2 2	11 11	6 11	11 11	3	54 staves @ 5 staves/day test 5 staves/day
147	mechanics for installtion and suport of staves total	61	166	18	12	102	57	77	56	
148	mechanics for installtion and suport of									
149 150	vertexing layers support cones design	25	5	5	5	5		5		assembly of vertexing layers comes in this WBS
151 152	support cones tooling design support cones test pieces fabricate	15 5	5 15	2	2	5		5	15	10k tooling, 5k material and closeouts test 2 nested cones
149 150 151 152 153 154 155	support cones test and iteration support cones fabricate	10 5	10 60	2	2	10 20	10	10 5	24	8 nested cones for 2 layers with services both sides
156	assembly and testing clamshell articulation mechanism design	5 40	10 10	2	2	10 10	10	10 10	3	
157	clamshell articulation mechanism prototype	10	20	2	2	5	5	5	45	25k precision machining, 10k kinetic mounts and tooling, 10k misc
	clamshell articulation mechanism test	10	15	2	2	15	10	15	5	lots of measurement and motion testing
158 159	iteration clamshell articulation mechanism	15	10	1	1	5	5	5	5	rarely correct the first time
160	fabricate	10	20	2	2	5	5	5	45	complete iteration in costs
161	assemble and test	5	10	1 -	1	10	10	10	-	same tests as last time. Measurement tooling and proceedure exists
162 163 164	assembly of half-barrels onto mechanics testing of half barrels patch panel design	5 5	10 2 1	5 2	10 2 2	10 8 3	10 8	10 8 3	3	1 half barrel/day should be small not many connectors
165	patch panel design patch panel fab	2	10	2	2	<b>3</b> 4	8	4	16	4 x pp services exit both sides of vertexing layers and 2 halves for the clamshell 4k each
166	mechanics for installtion and suport of									
167 168	vertexing layers total	167	213	26	33	125	73	110	145	
168 169 170 171	Carbon fiber spec types/modulus	15						5	125	
	procure maintain in certification	5 5	24						125 12	0.5k/month - monitor/freezer maint, etc. 2 years. tech 1 day/month
172 173 174 175	Carbon fiber total	2 <b>5</b>	24 <b>24</b>	0	0	n	0	5	12 137	o.org month - monitory neezer maint, etc. 2 years, tech 1 day/month
175				-	-	-	-	-		some overlap with MPGD mecanics as they will be installed together as
176	global									one package
177 178	main insertion rails and slides design tooling design	35 20	10 10			10		10		likely carbon many fiber pieces
180	tooling fabricate test pieces fabricate	5 5 -	25 25			10 5	4.5	10 5	15 7	15k tooling, 7k materials, rollers, rails in global supports and on detector halves
178 179 180 181 182 183	testing of test pieces iteration of tooling Iteration of test pieces	5 10 5	10 5 20			10 5 8	10	10 8	2 8 7	8k tooling change as before
183 184 185	fabrication of test pieces fabrication of insertion structures patch panel design	10 20	50 50 10	5	5	8 10 5		8 10 5	28	making at least 4 rails + roller mechanism, stops, adjustment, etc.
186	patch panel test fab	2	10	1	1	5	5	5	10	lots of machining, realtively close tolerances on big part
187	patch panel test	3	5	2	2	5	5	5	5	procure connectors, make strain relief and cable connector assessment

189 190 191 192 193 194 195 196 197 198 199 200 201 202 203 204 205 206	patch panel fab  mechanics global total  cooling system staves and discs  spec water cooling sytsem chiller system procure  design manifords, plumbing, monitoring test fab and iteration	3 <b>138</b> 10	10 <b>195</b>	8	8	78	30	73	32 <b>119</b>	need at least 4 @ 8k each	* number of cone
193 194 195 196 197 198 199 200 201	staves and discs  spec water cooling sytsem chiller system procure  design manifords, plumbing, monitoring test fab and iteration	10									
195 196 197 198 199 200 201 202	spec water cooling sytsem chiller system procure  design manifords, plumbing, monitoring test fab and iteration	10									
196 197 198 199 200 201 202	procure  design manifords, plumbing, monitoring test fab and iteration	10	_	_						assuming water for staves and discs, air cooling can be added later if	
198 199 200 201 202	test fab and iteration	2	5 2	5		10 2		10 2	25	successful. No change from all-silicon assume 25k	*
199 200 201 202		15 10	10 30	5 3	5 10	5 10		5 10	2 20	not full system but ~20% to test full system capability	
201	fabricate manifolds, plumbing install and test	5 5	40 20	3	15 10	15 10	15 10	15 10	30 8	not fail system but 20% to test fail system capability	
202	integration into slow control and monitor system	2	2	5	5	15	15	15	8		
<ul><li>203</li><li>204</li><li>205</li></ul>											
205	staves and discs cooling system total	49	109	24	45	67	40	67	93		
206	vertexing layers air system design and spec	25	10	10	5	20		20			
207	air system blower/chiller/conditioner spec	5		5		5		5			
208 209	air system blower/chiller/conditioner procure	5		5		45		5	160	80k for STAR PXL system 2 systems, one for testing, one installed	
	ducting and flow control design ducting and flow control test chain fab and test	15 5	10	10 5	10	15 15	10	15 15	8	4k for 3-D printed parts, 2k flow monitor + 2k feedback control 3k misc	
210 211 212	ducting and flow control iteration ducting and flow control fabricate	8	5 10	8	5 10	10 5	10	10 5	4	remake parts final parts	
212 213	assembly and testing integration into slow control and	2	10	2	10	5	5	5	1		
214 215	monitor system		3	3	5	10	10	10	2	2k for interfaces, etc.	
216 217	cooling system vertexing layers total	68	48	51	45	85	40	90	179		
217 218	RDO										
										assume that we can use a lot of what was done for ITS-2/3 but will need to modify to take advantage of mulyilexing on detector to reduce services.	
219	RDO board design			60				120		For this WBS, assume a lot of the work can be done by an instrumentation physicist like Jo Schambach.	
220 221	RDO board test run fabrication RDO board test			5 10	10	10	10	5 10	22	7k for layout fron schematic. 8k per board for 2 prototypes	
220 221 222 223 224	RDO board design iteration RDO board test run fabrication			15	5			30	22	7k for layout fron schematic. 8k per board for 2 prototypes	
	RDO board test			10	10	10	10	10	442	assuming MUX boards are successful, can reduce to ~25 (need 20) @ 4,5k	*
225	RDO board fabrcication run  RDO board production testing			5	5	5	66	5	113	a boards a day including troubleshooting and fix. 15k for test station	•
226 227 228 229 230 231 232 233	RDO board production testing  RDO crates design  RDO crates procure	15 5	5 5	10 5	5 5 5	5	00	10 5	15 70	could be integration subsystem. Assume 10 crates @ 7k/crate	
229	RDO crates procure  RDO crates/system test  RDO firmware and software support	5	5	5 100	5	5 260		5 260	2	2k misc testing equiment mostly scientific staff if available. Otherwise will need to use EE	
231 232	install and test/fix system	10	10	10	10	15	15	15	3	mostly scientific start if available. Carlet wise with need to use 22	
233	RDO cost total	35	25	235	60	310	101	480	247		
234	power systems									assuming DC-DC converter architecture. Serial powering will be a different	
236	silicon									estimate assuming implementation of layout (existing) onto custom PCB for	
237	DC-DC converters - spec			5		5		5		installtion in EIC at stave/disc periphery assemble the DC-DC vonverters and other components onto the stave	
238	DC-DC converter/components procure			5			5		88	transition PCBs need 752 for detector. Buy 800 assume \$100 each. Need \$10 for additional components each	*
238	assembly of stave transition PCBs DC-DC converters/stave transition - hot	5	5	5	10	10		10	35	assy house @ \$40/board. Assume 4:1 DC-DC to PCB for assy.	
240	test spec power supplies (external rack to			5	15	10	10	5	5	5k test station	
241	feed DC-DC converters)			5		5		5	400	standard 20V 1.5kW power supplies @ ~5k each (assume rad tolerant not	
242	procure power supplies			5		5		5	189	needed) ML @ 7, 16 @ discs + 2 spare = 27	*
243	integration into slow control and monitor system install and test/fix	5	5	15 5	20 15	60 20	20 20	30 20	35	includes stave/disc control system for power enable/monitor @ ~25k to produce and 20 days EE, 15 days ET, etc \$10k for slow control interfaces,	
243 244 245 246 247 248 249	Power system silicon total	10	<b>10</b>	<b>50</b>	6 <b>0</b>	115	<b>55</b>	<b>80</b>	355		
247 248	RDO		20	30		110	33	50	333	similar to silicon, standard power supplies for RDO	
249 250 251	LV power supply architecture design spec LV power supplies	5	5	10 5	5	10		5 5		mechanical somponent to this in feeding crates	
251	LV power supplies procure integration into slow control and			5				5	30	5 crates, buy 6 power supplies @ ~5k each	
252 253 254	monitor system set up and test/fix	2	2	5 5	10 10	15 10	15 10	15 10	20 3	use modified silicon system	
254 255	Power System RDO total	7	7	30	25	35	25	40	53		
255 256 257	multiplexing boards										
258	spec power supplies and architecture	5	5	10	5	10		5		accuracy F.1 maining up reduction, need (10 heards to neuron -> 2 neuron	
259	procure power supplies			5				5	15	assume 5:1 minimum reduction, need <18 boards to power => 3 power supplioes	
260	integration into slow control and monitor system set up and test/fix	2	2	5 5	10 10	15 10	15 10	15 10	20	use modified silicon system	
261 262	Power System multiplexing boards	2	2	J	10	10	10	10	3		
263 264 265	total	7	7	25	25	35	25	35	38		
265 266	slow control system  design slow control architecture			10		25		25		internal to silicon tracking but in overall experimental framework	
	procure pieces and prototype single chain			5	15	25 15	10	15	8	PC@ 3k, microcontroller board@1k, interfaces@2k, misc @ 2k	
267 268 269 270 271 272 273	test and design iteration procure components			5 5	5 5	10 5	10	5	5 22	10 controllers, 4 PCs, etc. Interfaces in the subsystem WBS	*
270 271	assemble system and test/fix			1	5	15	10	15	5	, -	
272 273	slow control system total	0	0	26	30	70	30	65	40		
	database (assembly, physical configuration									File into accordi distribute formation of the second of th	
274	and logging)									fits into overall database for experiment. Presume realtional oracle like database.	
275	define database parameters and relations	10		10		25		10			
276	design database structure/fields integrate database into detector fabrication and assembly process	5		5		15 30		15 30		add cost of database if not already supplied by project	
277	fabrication and assembly process implement and test/fix	5		5 5		30 20		30 20		add cost of database if flot already supplied by project	

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280	database (assembly, physical configuration, run configuration and logging) total	25	0	25	0	90	0	75	0	
280 281 282	services routing	25	U	25	U	90	U	75	U	
202	services routing									presume flex PCB from stave/disc to transition piece with DC-DC converters located there and daisy-chained to the requisite depth. cables
283	power cabling									from pp to stave/disc ends (Cu clad AI) and cables from pp to power supplies (Cu)
284 285	spec cabling staves to pp spec cabling discs to pp	10 10		8 8		8 8		8 8		
286 287	spec cabling vertexing layers to pp spec cabling pp to PS	5		5		5		5		
283 284 285 286 287 288 289 290	procure samples test and evaluate	1 5	10	1 5	10	10		10	3	
290	iterate design	5		5		5				average 2m length @\$2/m + \$50 per terminated end. Need 16 for
291	procure full power cabling detector to pp	2	5	2	5	3		3	11	vertexing, ML = 28, discs 3,4,5)=48, discs 2 = 16, disc 1 = 8, total = 100 power wires Assume that the PS are located 30m from the internal connections to the
292 293	procure full power cabling pp to PS test and bundle	5		5		5 5	5	5 2	18	stave/disc ends. \$1/meter + \$50 per terminated end * 4k tester,
292 293 294 295 296	power cabling total	43	15	39	15	49	5	41	32	
296										
297 298	signal cabling design final architecture	5		10		10		10		at this point we assume the standard Samtec twinax cabling internally to multiplexing boards and fiber connections out to the RDO boards
299	design multiplexing boards	3		10 25		10 15		10 15		
300 301	fabricate multiplexing board prototype MUX board firmware/software	2	2	5 15	10	5 40		5 40	17	5k layout, 6k per board x 2 boards
300 301 302 303	test iteration			10 15	5 5	15 15	5	15 15	3	
										assume 10:1 multiplexing for the stave and outer 3 disc layers, assume 1:1
304 305	fabricate multiplexing boards testing of boards			5 5	5 5	5 10	10	5 10	35 2	for vertexing and inner disc layers 10 MUX boards @ 3.5k each
306	procurement of samtec cables => mux boards				5	5		5	30	\$75 per cable, staves = 108, discs = 286
307 308	procurement of fibers => RDO boards				2	3	3	3	2	40 fibers @ \$50 each
307 308 309 310	signal cabling total	7	2	90	37	123	18	123	89	
311 312	environmental monitoring									could be integration subsystem but would still need to be integrated into the tracking mechanics/hardware
	define parameters to be monitored define hardware that fits into	5		5		10		10		temp on cooling lines, humidity, etc.
313 314 315 316	experimental monitoring systems procure	5 2	45	5 2	45	10 7	10	10 7	10	10k for monitoring devices and interfaces
316	install into tracking structures  services routing environmental	2	15	2	15	10	10	10		
317	monitoring total	14	15	14	15	37	10	37	10	
317 318 319	detector assembly									assemble disc and stave packages before installation - cradles, clamping,
320	Detector assembly tooling design detector assembly tooling fabricate	15 5	5 20	4 5	4 10	5 10	10	5 10	15	etc.  15k for cradles, leveling, clamps, etc
321 322	iteration and fixes detector package scaffholding and	5	10	3	3	10	10	10	5	
323	insertion cradle design detector package scaffholding and	10	5			5		5		hold detector halves externally as they slide in
324 325 326 327 328 329 330	insertion cradle fab detector assembly	5 5	15 20	5	10	5 15	15	5 15	20 15	80/20 or unistrut with rails, adjustment mechanisms, etc. large.  1 week per side half => 4 total weeks
326 327	detector cabling to patch panels detector testing/fix problems detector install	1 5	5 5	2 5	10 5	15 15	15 15	15 15	2	test as you go, mostly psotdoc/student/staff global testing tasks needed but in installtion WBS, listed here for completeness
329 330	detector cable detector test/fix problems									tasks needed but in installtion WBS, listed here for completeness tasks needed but in installtion WBS, listed here for completeness
	detector characterize and begin alignment with cosmic rays									tasks needed but in installtion WBS, listed here for completeness
331 332 333 334 335 336 337 338	detector assembly total	51	85	24	42	80	65	80	60	
334 335	silicon									
336 337	staves and discs wafer planning			25	25	25		25		
338	mask charge								540	200/ viald for story /disc silican, 071/200 gray varfor a 2 0 0004 m 22
339	wafers procurement thinning			10 60	10 60	10 60		10 60	1778 254	assume 40% yield for stave/disc silicon. ~7k/300 mm wafer => 0.0601 m^2 per wafer. 6.1 m^2/0.4 yield (full path)/0.0601 m^2 ~ 254 wafers * assume processing @ 1k/wafer *
341 342	dicing			60	60	60		60	126	assume 500/wafer *
339 340 341 342 343 344 345 346	silicon staves and discs total	0	0	155	155	155	0	155	2698	
	probe testing  probe card design	5	7	25	10	5		10	10	Flaterent 7k / sand 2 sands
347 348 349	probe card fabricate prototype probe card testing iterate	2 2	7 7 2	3 15 10	10 15 8	5 10 10		2 10 10	19 2 1	5k layout, 7k / card. 2 cards
350 351	probe cards fabricate probe machine tooling design	1 15	2	3	1	2		2	45	5 probe cards, @ 7k, 5x replacement probes @2k can be used on pick and place if that is used for probing
348 349 350 351 352 353 354	probe testing machine spec probe testing machine procure	3 2		5		-		5 2	80	one per testing site multiply for parallelism
354	probe test machine programming			10		15		15		QA chack on fab yield through wafer fab process 1/10 wafers => 25 at
355	probe testing of wafers	2	2	2	2	13		5	2	2/day dies are stitched, Assume 20 stitched reticle objects/wafer. => 5080 "dies".
356 357 358	probe testing of dies shipping and transportation					51 5	51 5	10 5	6	@100/day shipments of 200 dies @ \$200 each
358 359	silicon staves and discs probe testing	34	18	80	36	121	56	81	155	
359 360 361 362	vertexing layers									
	wafer planning			30		10		30		assume 10% yield. Need 8 wafers for outer layer, 4 for inner. Total wafers
363 364	wafers procurement thinning			10 5	10 5	10 10		10 10	840 120	needed is 120 * assume processing @ 1k/wafer
365 366	dicing shipping and transportation			5	5	10 5		10 5	60 5	assume 500/wafer large dies, special handling, special boxes => 5k
363 364 365 366 367 368 369 370	silicon vertexing layers total	0	0	50	20	45	0	65	1025	
370	probe testing									assume we can use the ITS-3 probe test card design - minor mods if
371 372 373	probe card design probe card fabricate	5 1	5 1	10 5	10 5	5		5	12	necessary 2 probe cards * 7k each
374	probe machine tooling fabricate probe testing machine procure	5 5	5	2 5	5	5		5	5 80	assume we can use the ITS-3 probe test tooling if needed at probe testing site - may already have
375 376	probe test machine programming probe testing of stitched dies	3 1	3 1	5 5	5 5	5 5	5	5 5	1	assume we can use the ITS-3 probe test programming assume 1 week for all sustant padded boxes @ 1k each 4 boxes 2k for transport
377	shipping and transportation	2	2	1	1	5	5	5	6	custom padded boxes @ 1k each, 4 boxes, 2k for transport

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378 379 380	vertexing layers probe testing total	22	17	33	31	25	10	25	104	
380										assumes that modules are assembeled at institutiona around the world and assembeled into staves and discs. The costing for the modules is here, the costing for assembly is in the individual detector component section.  ALICE ITS did 10 14-sensor modules per week per assembly machine
381 382	modules (staves and discs) die carrier trays design	5	5	2	2	5		5		pipelined
383	die carrier trays fabricate	3	3	1	1	10		10	6	need many, say 50 per assy site (each die carrier holds ~20) @ \$30 each
383 384 385 386 387 388	custom pick and place machine	25		25	г	25		25	150 125	one per assembly site multiply for parallelism  *
386	bonding machine tooling design	2 20	5	5	5 5	5 10		5 10	125	one per assembly site multiply for parallelism *
387	tooling test fab and iterate	5	15	5	5	15	5	15	15	15k - high tolerance machining
388	tooling fabricate	5	5	1	1	5	5	5	15	one per assembly site multiply for parallelism need uniformity among testing sites. 15k is for travel to inspect and
389 390	tooling assemble and qualify	5	5	2	2	10		10	15	validate assembly sites.
390	Al FPC design			10	5	5		5		
391	test fab and iterate x 2			20	20	35	30	30	15	assume modules are silicon glued and bonded to FPCs. Al FPCs in the stave and disc WBS join the FPCs on the modules to bring power and signal of joined modules to stave/disc periphery. FPC is Al conductor and of order 5x15 cm. Make 3 per iteration test, validate, make again x2 postdoc/student/staff time for QA and validation, EE, ET manage process
										and fix problems. Assume \$300 each FPC cost is highly dependant on FPC
392	fab Al FPCs			10	10	15	30	15	361	complexity *
393	asemble modules	20	602	20	602	80	80	80	5	scaling from 2300 modules, 6.14 m^2/11.74 m^2 * 2300 = 1203. we need 1203 modules. use ALICE ITS2 speed for now, we can probably go faster with faster drying adhesives 1203 modules/10 modules per week = 200 weeks x 2 people - includes wire bonding, testing, etc.
393 394	module carrier design	6	8	1	1	8		8	_	,
395 396	module carriers fabricate shipping of silicon to assy site	2	2	1	10	10 20	20	10 10	5 10	ITS-2 used machined aluminumn carrier plates with lids @ ~100 each, let's assume we can use plastic (antistatic) and go at \$1 each after investment in a \$4k mould. Neet at least 200 to keep up with shipping to assy sites shipping of stitched dies, assume same as for shipping of modules
397	shipping of modules to stave/disc assy site				10	20	20	10	10	shipments of 10 modules each @ \$50/shipment
397 398 399 400	modules (staves and discs) total	98	650	108	679	278	190	253	732	
	shipping of detector components to EIC									
401 402 403	ship staves from asy sites	5	8	1	2	13	15	5	25	custom boxes, 4/shipment 10k boxes, 1k/shipment
403	ship disc-halves from assy sites	5	8	1	2	7	13	5	30	custom boxes, 4/shipment 10k boxes, 1k/shipment hand deliver using airplane seats. 2 clamshell halves. 5k each for boxes,
404 405	ship vertex from assy site	5	8	1	2	6	3	6	15	2.5k each for two trips
406	shipping of detector components to EIC total	15	24	3	6	26	31	16	70	
407 408	travel									reviews, meetings, planning, personnel to BNL for assembly work
409	trips domestic								45	assume 2 trips 3 people each year for 3 years @ 2.5k/person/trip - time is in other WBS
410	trips foreign								90	assume 2 trips 3 people each year for 3 years @ 5k/person/trip - time is in other WBS
411 412 413	travel total	0	0	0	0	0	0	0	135	
413	total cost for hybrid (removed									
415 416	OL)	1550	2940	1440	1892	3000	1468	2578	7890	